TOSHIBA TC75W59FU/FK

TOSHIBA CMOS LINEAR INTEGRATED CIRCUIT SILICON MONOLITHIC

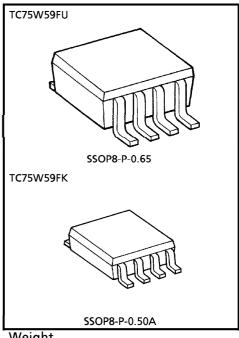
# TC75W59FU, TC75W59FK

### **DUAL COMPARATOR**

TC75W59 is a CMOS type general-purpose dual comparator capable of single power supply operation and using lower supply currents than the conventional bipolar comparators. Its open drain output forms wired OR with other open drain outputs.

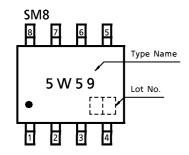
#### **FEATURES**

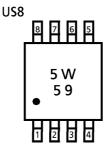
- Low supply current : I<sub>DD</sub> = 200 μA (Typ.)
- Single power supply operation
- Wide common mode input voltage range: VSS~VDD 0.9V
- Open drain output circuit
- Low input bias current
- Small package



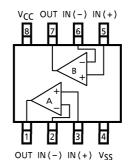
Weight SSOP8-P-0.65 : 0.021g (Typ.) SSOP8-P-0.50A : 0.01g (Typ.)

#### MARKING (TOP VIEW)





#### PIN CONNECTION (TOP VIEW)



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### **MAXIMUM RATINGS** (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	N	
Supply Voltage	V <sub>DD</sub> , V <sub>SS</sub>	±3.5 or 7	V	
Differential Input Voltage	DVIN	± 7	V	
Input Voltage	V <sub>IN</sub>	$V_{SS} \sim V_{DD}$	V	
Output Current	lo	± 35	mA	
Power Dissipation	D-	250 (SM8)	mW	
Fower Dissipation	PD	200 (US8)	11100	
Operating Temperature	T <sub>opr</sub>	<b>- 40∼8</b> 5	°C	
Storage Temperature	T <sub>stg</sub>	<b>-</b> 55∼125	°C	

(Note) Since this product sometimes brings about latchup, which is peculiar to CMOS devices, note the following points :

- Don't raise the voltage level of I/O pins beyond V<sub>DD</sub>, nor lower it below V<sub>SS</sub>.
   Consider the timing for power supply, too.
- Don't let any abnormal noise enter the device.

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# **ELECTRICAL CHARACTERISTICS** ( $V_{DD} = 5V$ , $V_{SS} = GND$ , Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Input Offset Voltage	V <sub>IO</sub>	_	_	_	± 1	± 7	mV
Input Offset Current	lo	_	_	_	1	_	pА
Input Bias Current	Ц	_	_	_	1	_	pА
Common Mode Input Voltage	CMVIN	_	_	0	_	4.1	٧
Supply Current	I <sub>DD</sub> (Note)	_	<del>-</del>	_	220	440	μΑ
Voltage Gain	GV	_	<del>-</del>	_	94	_	dB
Sink Current	l <sub>sink</sub>	_	V <sub>OL</sub> = 0.5V	13	25	_	mA
Output Leak Current	ILEAK	_	V <sub>O</sub> = 5V	_	5	_	nA
Output Voltage	VOL	_	l <sub>sink</sub> = 5.0mA	_	0.1	0.3	V
Operating Supply Voltage	V <sub>DD</sub>	_	_	1.8	_	7.0	٧
Propagation Delay	<sup>t</sup> PLH (1)	_	Over drive = 100mV	_	200	_	ne
Time (Turn ON)	<sup>t</sup> PLH (2)	_	TTL step input	_	140	_	ns
Propagation Delay	tPHL (1)	_	Over drive = 100mV	_	80	_	ns
Time (Turn OFF)	tPHL (2)	_	TTL step input	_	60		
Response Time t <sub>TLI</sub>	tTLH	_	Over drive = 100mV	_	160	_	ns
	tTHL	_	Over drive = 100mV	_	3	_	

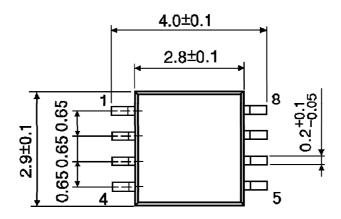
# **ELECTRICAL CHARACTERISTICS** ( $V_{DD} = 3V$ , $V_{SS} = GND$ , Ta = 25°C)

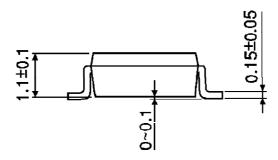
CHARACTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Input Offset Voltage	V <sub>IO</sub>	_	_	_	± 1	±7	mV
Input Offset Current	lo	_	_	_	1	_	pА
Input Bias Current	Ц	_	_	_	1	_	pА
Common Mode Input Voltage	CMVIN	_	_	0	_	2.1	٧
Supply Current	I <sub>DD</sub> (Note)	_	_	_	200	400	μΑ
Sink Current	l <sub>sink</sub>	_	V <sub>OL</sub> = 0.5V	6	18	_	mA
Output Leak Current	ILEAK	_	V <sub>O</sub> = 3V	_	5	_	nA
Output Voltage	V <sub>OL</sub>	_	I <sub>sink</sub> = 5.0mA	_	0.15	0.35	<b>\</b>
Propagation Delay Time (Turn ON)	t <sub>PLH</sub>	_	Over drive = 100mV	_	160	_	ns
Propagation Delay Time (Turn OFF)	tPHL	_	Over drive = 100mV	_	70	_	ns
Response Time	tTLH	_	Over drive = 100mV	_	170	_	ns
	tTHL	_	Over drive = 100mV	_	3	_	ns

(Note) Since this product causes an increase in current consumption with a rise in operational frequency, make sure that power consumption does not exceed the allowable dissipation.

#### OUTLINE DRAWING SSOP8-P-0.65

Unit: mm

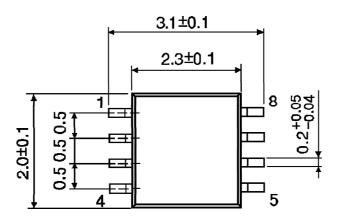


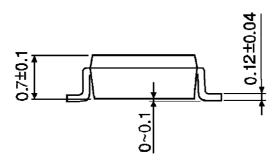


Weight: 0.021g (Typ.)

#### OUTLINE DRAWING SSOP8-P-0.50A

Unit: mm





Weight: 0.01g (Typ.)